

3.3V, Low Power, 30Mbps, RS-485/RS-422 Transceiver

The Intersil ISL43485 is a high speed BiCMOS 3.3V powered, single transceiver that meets both the RS-485 and RS-422 standards for balanced communication. Unlike some competitive devices, this Intersil transceiver is specified for 10% tolerance supplies (3V to 3.6V).

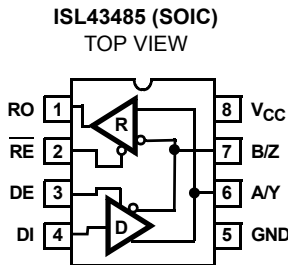
Data rates up to 30Mbps are achievable by using this transceiver, which features higher slew rates.

Logic inputs (e.g., DI and DE) accept signals in excess of 5.5V, making them compatible with 5V logic families.

Receiver (Rx) inputs feature a “fail-safe if open” design, which ensures a logic high output if Rx inputs are floating, and the ISL43485 presents a “single unit load” to the RS-485 bus, which allows up to 32 transceivers on the network.

Driver (Tx) outputs are short circuit protected, even for voltages exceeding the power supply voltage. Additionally, on-chip thermal shutdown circuitry disables the Tx outputs to prevent damage if power dissipation becomes excessive.

Pinout



Features

- High Data Rate. up to 30Mbps
- Operates from a Single +3.3V Supply (10% Tolerance)
- Interoperable with 5V Logic
- Single Unit Load Allows up to 32 Devices on the Bus
- Low Current Shutdown Mode. 15nA
- -7V to +12V Common Mode Input Voltage Range
- Three State Rx and Tx Outputs
- 10ns Propagation Delay, 1ns Skew
- Half Duplex Pinout
- Current Limiting and Thermal Shutdown for driver Overload Protection
- Pb-Free Available (RoHS Compliant)

Applications

- SCSI “Fast 20” Drivers and Receivers
- Factory Automation
- Data Loggers
- Security Networks
- Building Environmental Control Systems
- Industrial/Process Control Networks
- Level Translators

Ordering Information

PART NO. (BRAND)	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
ISL43485IB (43485IB)	-40 to 85	8 Ld SOIC	M8.15
ISL43485IBZ (43485IB) (Note)	-40 to 85	8 Ld SOIC (Pb-free)	M8.15
ISL43485IB-T (43485IB)	-40 to 85	8 Ld SOIC Tape and Reel	M8.15
ISL43485IBZ-T (43485IB) (Note)	-40 to 85	8 Ld SOIC Tape and Reel (Pb-free)	M8.15

NOTE: Intersil Pb-free products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

Truth Tables

TRANSMITTING				
INPUTS			OUTPUTS	
\overline{RE}	DE	DI	Z	Y
X	1	1	0	1
X	1	0	1	0
0	0	X	High-Z	High-Z
1	0	X	High-Z *	High-Z *

NOTE: *Shutdown Mode

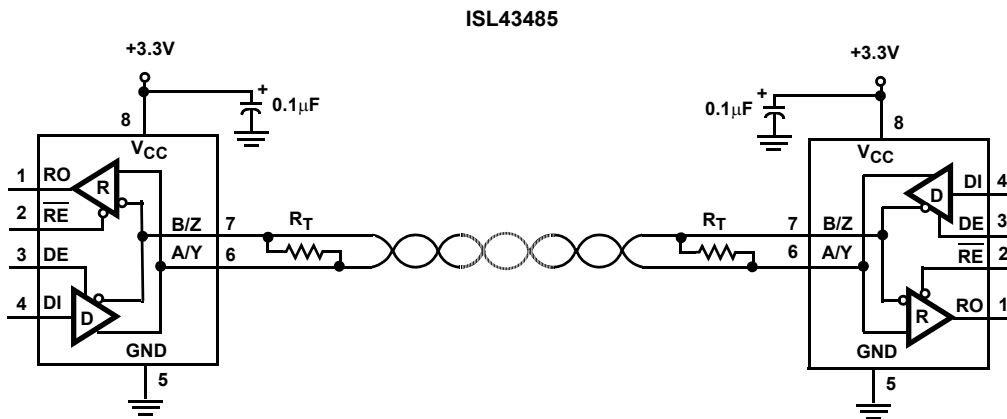
RECEIVING			
INPUTS			OUTPUT
\overline{RE}	DE	A-B	RO
0	0	$\geq +0.2V$	1
0	0	$\leq -0.2V$	0
0	0	Inputs Open	1
1	0	X	High-Z *
1	1	X	High-Z

NOTE: *Shutdown Mode

Pin Descriptions

PIN	FUNCTION
RO	Receiver output: If $A > B$ by at least 0.2V, RO is high; If $A < B$ by 0.2V or more, RO is low; RO = High if A and B are unconnected (floating).
\overline{RE}	Receiver output enable. RO is enabled when \overline{RE} is low; RO is high impedance when \overline{RE} is high.
DE	Driver output enable. The driver outputs, Y and Z, are enabled by bringing DE high. They are high impedance when DE is low.
DI	Driver input. A low on DI forces output Y low and output Z high. Similarly, a high on DI forces output Y high and output Z low.
GND	Ground connection.
A/Y	Noninverting receiver input and noninverting driver output. Pin is an input if DE = 0; pin is an output if DE = 1.
B/Z	Inverting receiver input and inverting driver output. Pin is an input if DE = 0; pin is an output if DE = 1.
V _{CC}	System power supply input (3V to 3.6V).

Typical Operating Circuit



Absolute Maximum Ratings

V _{CC} to Ground	7V
Input Voltages	
DI, DE, RE	-0.5V to +7V
Input/Output Voltages	
A/Y, B/Z	-8V to +12.5V
RO	-0.5V to (V _{CC} +0.5V)
Short Circuit Duration	
Y, Z	Continuous

Thermal Information

Thermal Resistance (Typical, Note 1)	θ_{JA} (°C/W)
8 Ld SOIC Package	170
Maximum Junction Temperature (Plastic Package)	150°C
Maximum Storage Temperature Range	-65°C to 150°C
Maximum Lead Temperature (Soldering 10s) (Lead Tips Only)	300°C

Operating Conditions

Temperature Range	
ISL43485I	-40°C to 85°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

- θ_{JA} is measured with the component mounted on a low effective thermal conductivity test board in free air. See Tech Brief TB379 for details.

Electrical Specifications Test Conditions: V_{CC} = 3V to 3.6V; Unless Otherwise Specified. Typical values are at V_{CC} = 3.3V, T_A = 25°C, Note 2

PARAMETER	SYMBOL	TEST CONDITIONS	TEMP (°C)	MIN	TYP	MAX	UNITS	
DC CHARACTERISTICS								
Driver Differential V _{OUT} (no load)	V _{OD1}		Full	-	-	V _{CC}	V	
Driver Differential V _{OUT} (with load)	V _{OD2}	R _L = 100Ω (RS-422) (Figure 1A)	Full	2	2.7	-	V	
		R _L = 54Ω (RS-485) (Figure 1A)	Full	1.5	2.3	V _{CC}	V	
		R _L = 60Ω, -7V ≤ V _{CM} ≤ 12V (Figure 1B)	Full	1.5	2.6	-	V	
Change in Magnitude of Driver Differential V _{OUT} for Complementary Output States	ΔV _{OD}	R _L = 54Ω or 100Ω (Figure 1A)	Full	-	0.01	0.2	V	
Driver Common-Mode V _{OUT}	V _{OC}	R _L = 54Ω or 100Ω (Figure 1A)	Full	-	1.8	3	V	
Change in Magnitude of Driver Common-Mode V _{OUT} for Complementary Output States	ΔV _{OC}	R _L = 54Ω or 100Ω (Figure 1A)	Full	-	0.01	0.2	V	
Logic Input High Voltage	V _{IH}	DE, DI, \overline{RE}	Full	2	-	-	V	
Logic Input Low Voltage	V _{IL}	DE, DI, \overline{RE}	Full	-	-	0.8	V	
Logic Input Current	I _{IN1}	DE, DI	Full	-2	-	2	μA	
		\overline{RE}	Full	-25	-	25	μA	
Input Current (A/Y, B/Z)	I _{IN2}	DE = 0V, V _{CC} = 0V or 3.6V	V _{IN} = 12V	Full	-	0.6	1	mA
			V _{IN} = -7V	Full	-	-0.3	-0.8	mA
Receiver Differential Threshold Voltage	V _{TH}	-7V ≤ V _{CM} ≤ 12V	Full	-0.2	-	0.2	V	
Receiver Input Hysteresis	ΔV _{TH}	V _{CM} = 0V	25	-	50	-	mV	
Receiver Output High Voltage	V _{OH}	I _O = -4mA, V _{ID} = 200mV	Full	V _{CC} - 0.4	-	-	V	
Receiver Output Low Voltage	V _{OL}	I _O = -4mA, V _{ID} = 200mV	Full	-	-	0.4	V	

Electrical Specifications Test Conditions: $V_{CC} = 3V$ to $3.6V$; Unless Otherwise Specified. Typicals are at $V_{CC} = 3.3V$, $T_A = 25^{\circ}C$, Note 2 (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS	TEMP (°C)	MIN	TYP	MAX	UNITS	
Three-State (high impedance) Receiver Output Current	I_{OZR}	$0.4V \leq V_O \leq 2.4V$	Full	-1	-	1	μA	
Receiver Input Resistance	R_{IN}	$-7V \leq V_{CM} \leq 12V$	Full	12	19	-	$k\Omega$	
No-Load Supply Current (Note 3)	I_{CC}	$DI = 0V$ or V_{CC}	$DE = V_{CC}$, $\overline{RE} = 0V$ or V_{CC}	Full	-	0.75	1.2	mA
			$DE = 0V$, $\overline{RE} = 0V$	Full	-	0.65	1	mA
Shutdown Supply Current	I_{SHDN}	$DE = 0V$, $\overline{RE} = V_{CC}$, $DI = 0V$ or V_{CC}	Full	-	15	100	nA	
Driver Short-Circuit Current, $V_O =$ High or Low	I_{OSD1}	$DE = V_{CC}$, $-7V \leq V_Y$ or $V_Z \leq 12V$ (Note 4)	Full	-	-	250	mA	
Receiver Short-Circuit Current	I_{OSR}	$0V \leq V_O \leq V_{CC}$	Full	8	-	60	mA	
DRIVER SWITCHING CHARACTERISTICS								
Maximum Data Rate	f_{MAX}	(Figure 2A)	Full	30	50	-	Mbps	
Driver Differential Output Delay	t_{DD}	$R_{DIFF} = 60\Omega$, $C_L = 15pF$ (Figure 2A)	Full	3	10	25	ns	
Driver Differential Rise or Fall Time	t_R , t_F	$R_{DIFF} = 60\Omega$, $C_L = 15pF$ (Figure 2A)	Full	3	6	12	ns	
Driver Input to Output Delay	t_{PLH} , t_{PHL}	$R_L = 27\Omega$, $C_L = 15pF$ (Figure 2C)	Full	6	10	22	ns	
Driver Output Skew	t_{SKEW}	$R_L = 27\Omega$, $C_L = 15pF$ (Figure 2C)	Full	-	1	5	ns	
Driver Enable to Output High	t_{ZH}	$R_L = 110\Omega$, $C_L = 50pF$, $SW = GND$ (Figure 3), (Note 5)	Full	-	45	90	ns	
Driver Enable to Output Low	t_{ZL}	$R_L = 110\Omega$, $C_L = 50pF$, $SW = V_{CC}$ (Figure 3), (Note 5)	Full	-	45	90	ns	
Driver Disable from Output High	t_{HZ}	$R_L = 110\Omega$, $C_L = 50pF$, $SW = GND$ (Figure 3)	Full	-	60	90	ns	
Driver Disable from Output Low	t_{LZ}	$R_L = 110\Omega$, $C_L = 50pF$, $SW = V_{CC}$ (Figure 3)	Full	-	70	100	ns	
Driver Enable from Shutdown to Output High	$t_{ZH}(SHDN)$	$R_L = 110\Omega$, $C_L = 50pF$, $SW = GND$ (Figure 3), (Notes 7, 8)	Full	-	115	150	ns	
Driver Enable from Shutdown to Output Low	$t_{ZL}(SHDN)$	$R_L = 110\Omega$, $C_L = 50pF$, $SW = V_{CC}$ (Figure 3), (Notes 7, 8)	Full	-	115	150	ns	
RECEIVER SWITCHING CHARACTERISTICS								
Maximum Data Rate	f_{MAX}	$V_{ID} \geq 1.5V$ with $t_r/t_f = 10ns$, RO t_H & $t_L \geq 60\%$ t_{UI} (Figure 4)	Full	27	35	-	Mbps	
Receiver Input to Output Delay	t_{PLH} , t_{PHL}	(Figure 4)	Full	25	45	80	ns	
Receiver Skew $t_{PLH} - t_{PHL}$	t_{SKD}	(Figure 4)	Full	-	2	12	ns	
Receiver Enable to Output High	t_{ZH}	$R_L = 1k\Omega$, $C_L = 15pF$, $SW = GND$ (Figure 5), (Note 6)	Full	-	11	25	ns	
Receiver Enable to Output Low	t_{ZL}	$R_L = 1k\Omega$, $C_L = 15pF$, $SW = V_{CC}$ (Figure 5), (Note 6)	Full	-	11	25	ns	
Receiver Disable from Output High	t_{HZ}	$R_L = 1k\Omega$, $C_L = 15pF$, $SW = GND$ (Figure 5)	Full	-	7	20	ns	
Receiver Disable from Output Low	t_{LZ}	$R_L = 1k\Omega$, $C_L = 15pF$, $SW = V_{CC}$ (Figure 5)	Full	-	7	20	ns	

Electrical Specifications Test Conditions: $V_{CC} = 3V$ to $3.6V$; Unless Otherwise Specified. Typicals are at $V_{CC} = 3.3V$, $T_A = 25^\circ C$, Note 2 (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS	TEMP (°C)	MIN	TYP	MAX	UNITS
Time to Shutdown	t_{SHDN}	(Note 7)	Full	80	190	300	ns
Receiver Enable from Shutdown to Output High	$t_{ZH(SHDN)}$	$R_L = 1k\Omega$, $C_L = 15pF$, SW = GND (Figure 5), (Notes 7, 9)	Full	-	240	400	ns
Receiver Enable from Shutdown to Output Low	$t_{ZL(SHDN)}$	$R_L = 1k\Omega$, $C_L = 15pF$, SW = V_{CC} (Figure 5), (Notes 7, 9)	Full	-	240	400	ns

NOTES:

- All currents into device pins are positive; all currents out of device pins are negative. All voltages are referenced to device ground unless otherwise specified.
- Supply current specification is valid for loaded drivers when $DE = 0V$.
- Applies to peak current. See "Typical Performance Curves" for more information.
- When testing this parameter, keep $\overline{RE} = 0$ to prevent the device from entering SHDN.
- When testing this parameter, the \overline{RE} signal high time must be short enough (typically $<100ns$) to prevent the device from entering SHDN.
- The ISL43485 is put into shutdown by bringing \overline{RE} high and DE low. If the inputs are in this state for less than 80ns, the parts are guaranteed not to enter shutdown. If the inputs are in this state for at least 300ns, the parts are guaranteed to have entered shutdown. See "Low-Power Shutdown Mode" section.
- Keep $\overline{RE} = V_{CC}$, and set the DE signal low time $>300ns$ to ensure that the device enters SHDN.
- Set the \overline{RE} signal high time $>300ns$ to ensure that the device enters SHDN.

Test Circuits and Waveforms

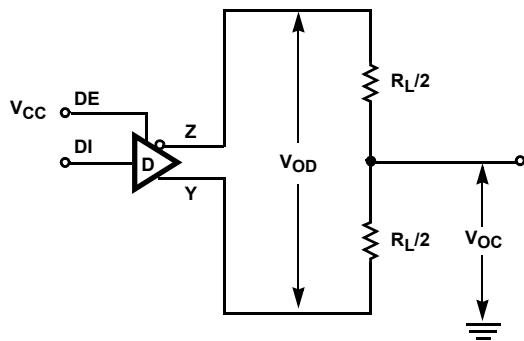


FIGURE 1A. V_{OD} AND V_{OC}

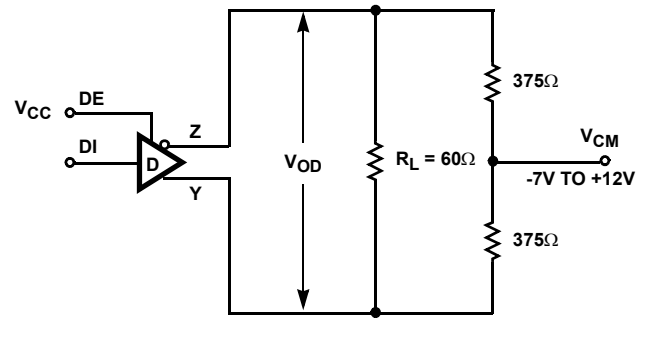


FIGURE 1B. V_{OD} WITH COMMON MODE LOAD

FIGURE 1. DC DRIVER TEST CIRCUITS

Test Circuits and Waveforms (Continued)

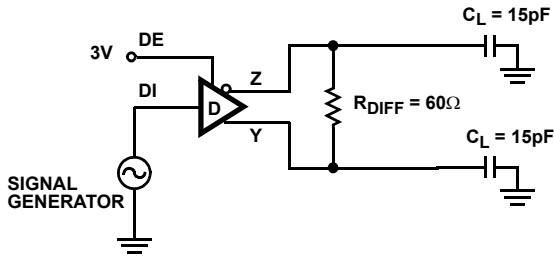


FIGURE 2A. DIFFERENTIAL TEST CIRCUIT

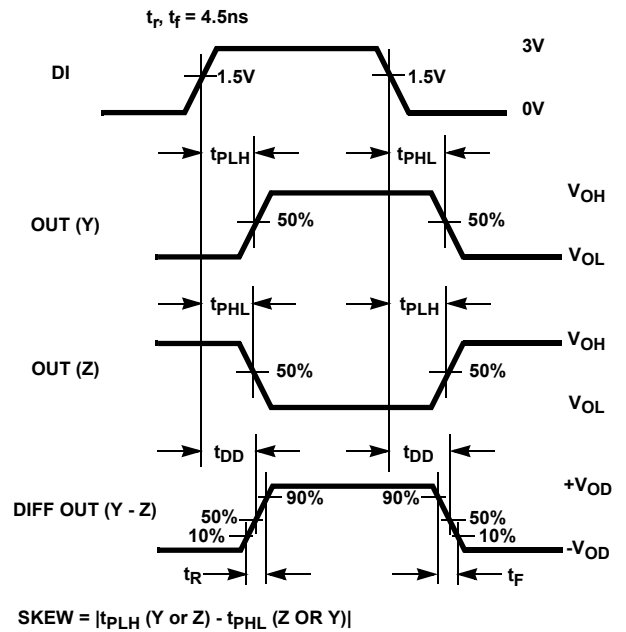


FIGURE 2B. MEASUREMENT POINTS

FIGURE 2C. SINGLE ENDED TEST CIRCUIT

FIGURE 2. DRIVER DATA RATE, PROPAGATION DELAY AND DIFFERENTIAL TRANSITION TIMES

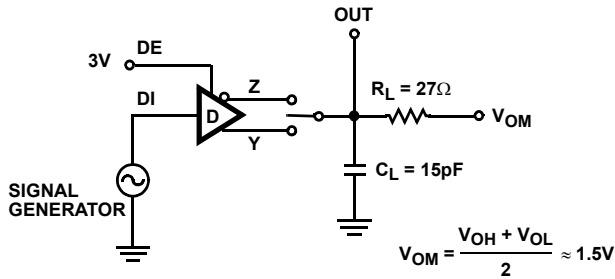


FIGURE 2C. SINGLE ENDED TEST CIRCUIT

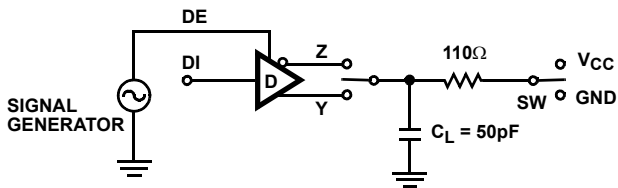


FIGURE 3A. TEST CIRCUIT

PARAMETER	OUTPUT	\overline{RE}	DI	SW
t_{HZ}	Y/Z	X	1/0	GND
t_{LZ}	Y/Z	X	0/1	V_{CC}
t_{ZH}	Y/Z	0 (Note 5)	1/0	GND
t_{ZL}	Y/Z	0 (Note 5)	0/1	V_{CC}
$t_{ZH(SHDN)}$	Y/Z	1 (Note 8)	1/0	GND
$t_{ZL(SHDN)}$	Y/Z	1 (Note 8)	0/1	V_{CC}

FIGURE 3. DRIVER ENABLE AND DISABLE TIMES

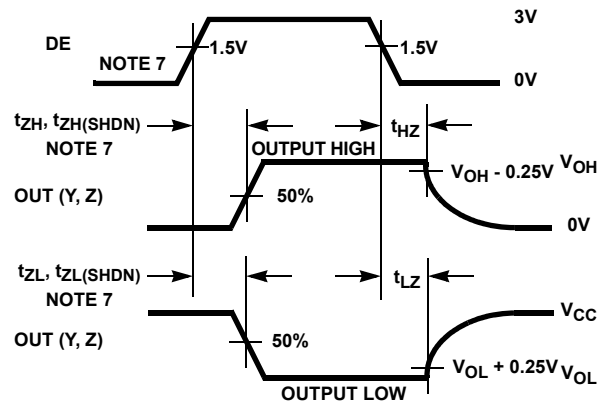


FIGURE 3B. MEASUREMENT POINTS

Test Circuits and Waveforms (Continued)

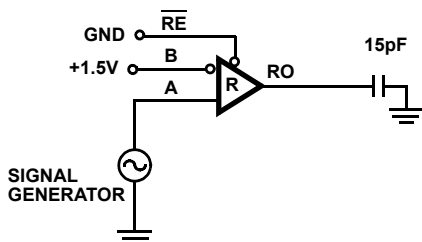


FIGURE 4A. TEST CIRCUIT

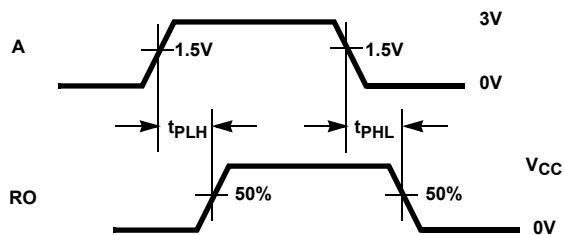


FIGURE 4B. MEASUREMENT POINTS

FIGURE 4. RECEIVER DATA RATE AND PROPAGATION DELAY

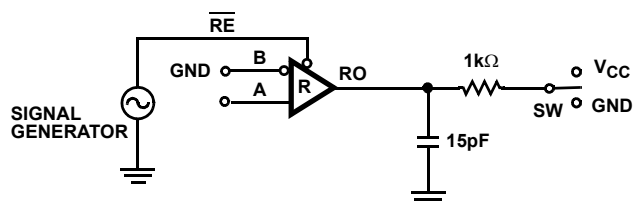


FIGURE 5A. TEST CIRCUIT

PARAMETER	DE	A	SW
t_{HZ}	0	+1.5V	GND
t_{LZ}	0	-1.5V	V_{CC}
t_{ZH} (Note 6)	0	+1.5V	GND
t_{ZL} (Note 6)	0	-1.5V	V_{CC}
$t_{ZH(SHDN)}$ (Note 9)	0	+1.5V	GND
$t_{ZL(SHDN)}$ (Note 9)	0	-1.5V	V_{CC}

FIGURE 5. RECEIVER ENABLE AND DISABLE TIMES

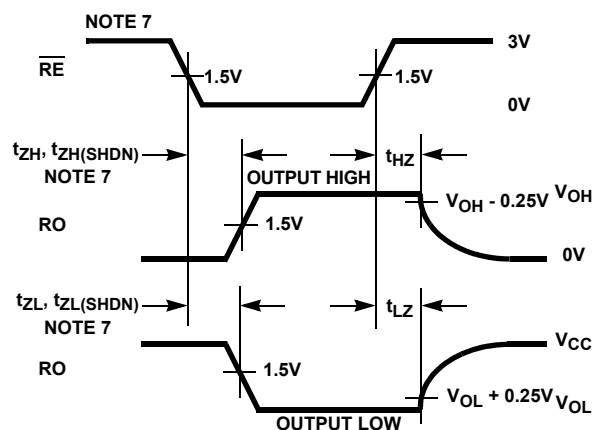


FIGURE 5B. MEASUREMENT POINTS

Application Information

RS-485 and RS-422 are differential (balanced) data transmission standards for use in long haul or noisy environments. RS-422 is a subset of RS-485, so RS-485 transceivers are also RS-422 compliant. RS-422 is a point-to-multipoint (multidrop) standard, which allows only one driver and up to 10 (assuming one unit load devices) receivers on each bus. RS-485 is a true multipoint standard, which allows up to 32 one unit load devices (any combination of drivers and receivers) on each bus. To allow for multipoint operation, the RS-485 spec requires that drivers must handle bus contention without sustaining any damage.

Another important advantage of RS-485 is the extended common mode range (CMR), which specifies that the driver outputs and receiver inputs withstand signals that range from +12V to -7V. RS-422 and RS-485 are intended for runs as long as 4000', so the wide CMR is necessary to handle ground potential differences, as well as voltages induced in the cable by external fields.

Receiver Features

This device utilizes a differential input receiver for maximum noise immunity and common mode rejection. Input sensitivity is $\pm 200\text{mV}$, as required by the RS422 and RS-485 specifications.

Receiver input impedance surpasses the RS-422 spec of $4\text{k}\Omega$, and meets the RS-485 "Unit Load" requirement of $12\text{k}\Omega$ minimum.

Receiver inputs function with common mode voltages as great as +9V/-7V outside the power supplies (i.e., +12V and -7V), making them ideal for long networks where induced voltages are a realistic concern.

All the receivers include a "fail-safe if open" function that guarantees a high level receiver output if the receiver inputs are unconnected (floating).

The receiver easily meets the data rate supported by the driver, and the receiver output is tri-statable via the active low $\overline{\text{RE}}$ input.

Driver Features

The RS-485, RS-422 driver is a differential output device that delivers at least 1.5V across a 54Ω load (RS-485), and at least 2V across a 100Ω load (RS-422) even with $V_{CC} = 3V$. The driver features low propagation delay skew to maximize bit width, and to minimize EMI, and it is tri-statable via the active high DE input.

Outputs of the ISL43485 driver are not slew rate limited, so faster output transition times allow data rates of at least 30Mbps.

Data Rate, Cables, and Terminations

Twisted pair is the cable of choice for RS-485, RS-422 networks. Twisted pair cables tend to pick up noise and other electromagnetically induced voltages as common mode signals, which are effectively rejected by the differential receivers in this IC.

RS-485, RS-422 are intended for network lengths up to 4000', but the maximum system data rate decreases as the transmission length increases. Devices operating at 30Mbps are often limited to lengths of less than one hundred feet. Figure 6 details the ISL43485's 30Mbps performance driving 200' of "CAT5" cable terminated in 120Ω at both ends. Note that the differential signal delivered to the receiver at the end of the cable (A-B) still exceeds 1.5V peak. Longer cable lengths are possible by reducing the data rate, as shown in Figure 7 for a data rate of 20Mbps.

To minimize reflections, proper termination is imperative when using this 30Mbps device. In point-to-point, or point-to-multipoint (single driver on bus) networks, the main cable should be terminated in its characteristic impedance (typically 120Ω) at the end farthest from the driver. In multi-receiver applications, stubs connecting receivers to the main cable should be kept as short as possible. Multipoint (multi-driver) systems require that the main cable be terminated in its characteristic impedance at both ends. Stubs connecting a transceiver to the main cable should be kept as short as possible.

Built-In Driver Overload Protection

As stated previously, the RS-485 spec requires that drivers survive worst case bus contentions undamaged. The ISL43485 meets this requirement via driver output short circuit current limits, and on-chip thermal shutdown circuitry.

The driver output stages incorporate short circuit current limiting circuitry which ensures that the output current never exceeds the RS-485 spec, even at the common mode voltage range extremes. Additionally, it utilizes a foldback circuit which reduces the short circuit current, and thus the power dissipation, whenever the contending voltage exceeds either supply.

In the event of a major short circuit condition, this device also includes a thermal shutdown feature that disables the drivers whenever the die temperature becomes excessive. This eliminates the power dissipation, allowing the die to cool. The drivers automatically reenables after the die temperature drops about 15 degrees. If the contention persists, the thermal shutdown/reenable cycle repeats until the fault is cleared. Receivers stay operational during thermal shutdown.

Low Power Shutdown Mode

This BiCMOS transceiver uses a fraction of the power required by its bipolar counterparts, nevertheless, the ISL43485 includes a shutdown feature that reduces the already low quiescent I_{CC} to a 15nA trickle. They enter shutdown whenever the receiver and driver are **simultaneously** disabled ($\overline{RE} = V_{CC}$ and $DE = GND$) for a period of at least 300ns. Disabling both the driver and the receiver for less than 80ns guarantees that shutdown is not entered.

Note that receiver and driver enable times increase when these devices enable from shutdown. Refer to Notes 5-9, at the end of the Electrical Specification table, for more information.

Typical Performance Curves $V_{CC} = 3.3V$, $T_A = 25^\circ C$; Unless Otherwise Specified

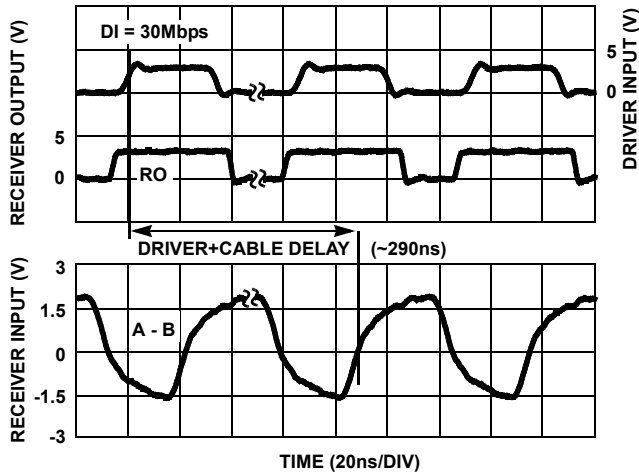


FIGURE 6. DRIVER AND RECEIVER WAVEFORMS DRIVING 200 FEET OF CAT5 CABLE (DOUBLE TERMINATED WITH 120Ω)

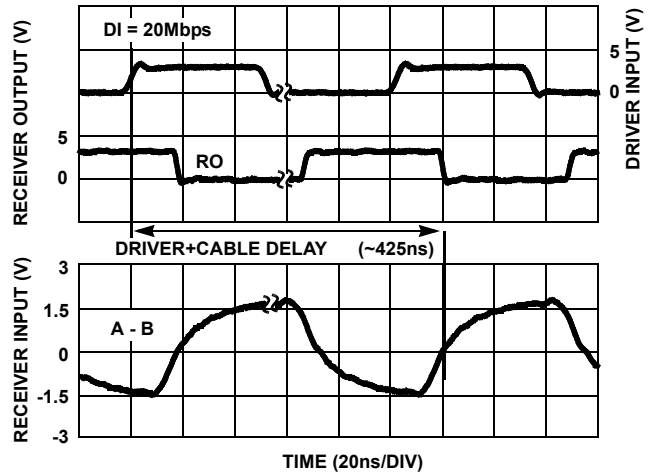


FIGURE 7. DRIVER AND RECEIVER WAVEFORMS DRIVING 300 FEET OF CAT5 CABLE (DOUBLE TERMINATED WITH 120Ω)

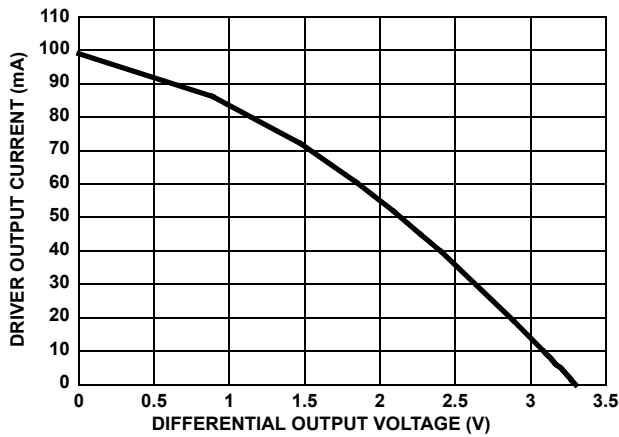


FIGURE 8. DRIVER OUTPUT CURRENT vs DIFFERENTIAL OUTPUT VOLTAGE

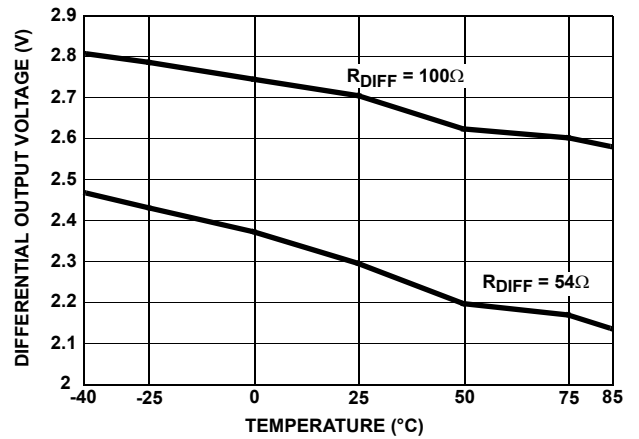


FIGURE 9. DRIVER DIFFERENTIAL OUTPUT VOLTAGE vs TEMPERATURE

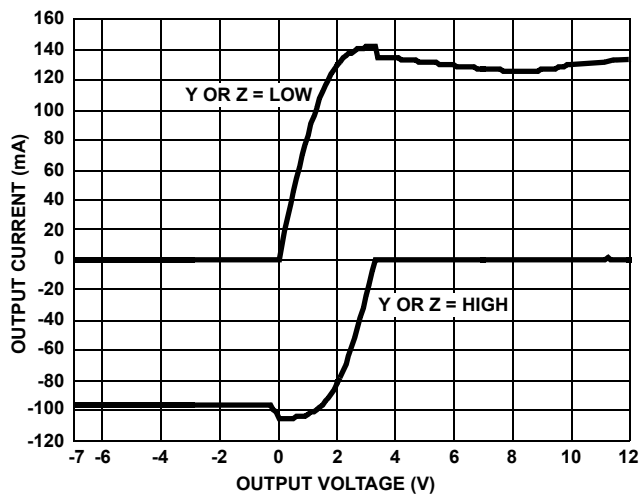


FIGURE 10. DRIVER OUTPUT CURRENT vs SHORT CIRCUIT VOLTAGE

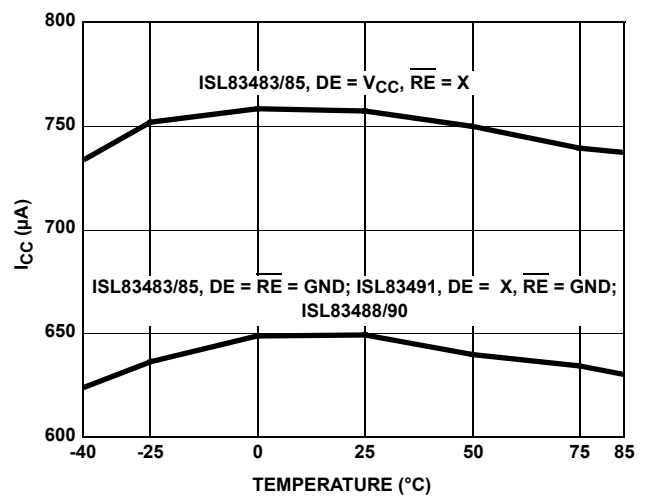


FIGURE 11. SUPPLY CURRENT vs TEMPERATURE

Typical Performance Curves $V_{CC} = 3.3V$, $T_A = 25^\circ C$; Unless Otherwise Specified (Continued)

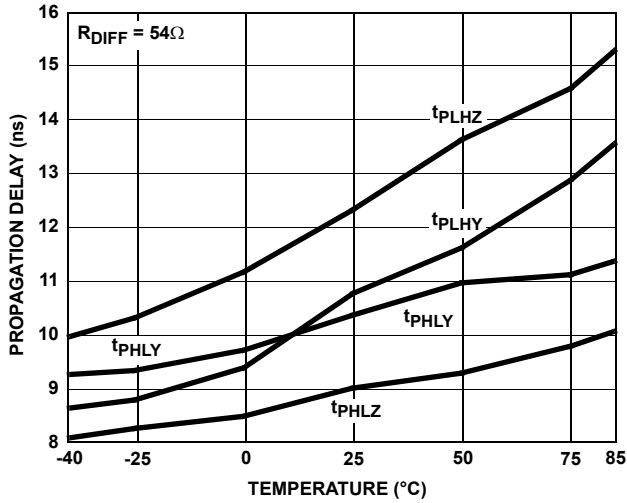


FIGURE 12. DRIVER PROPAGATION DELAY vs TEMPERATURE

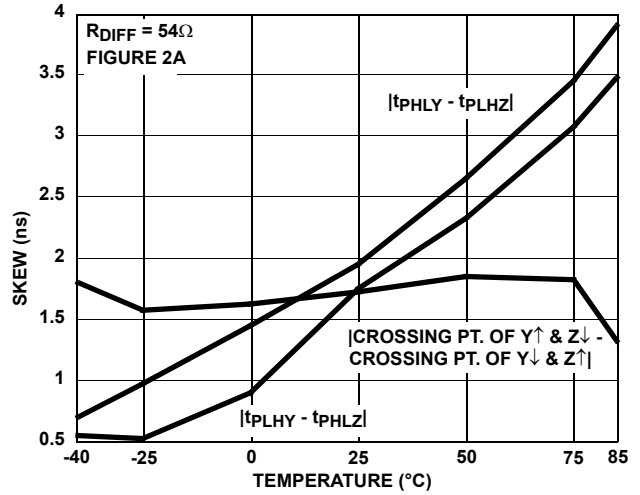


FIGURE 13. DRIVER SKEW vs TEMPERATURE

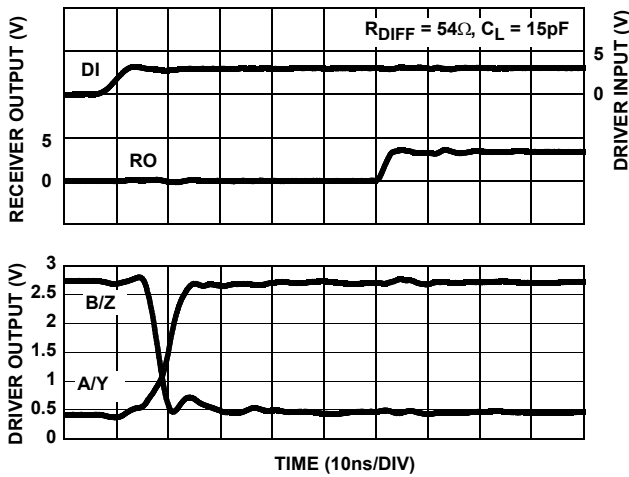


FIGURE 14. DRIVER AND RECEIVER WAVEFORMS, LOW TO HIGH

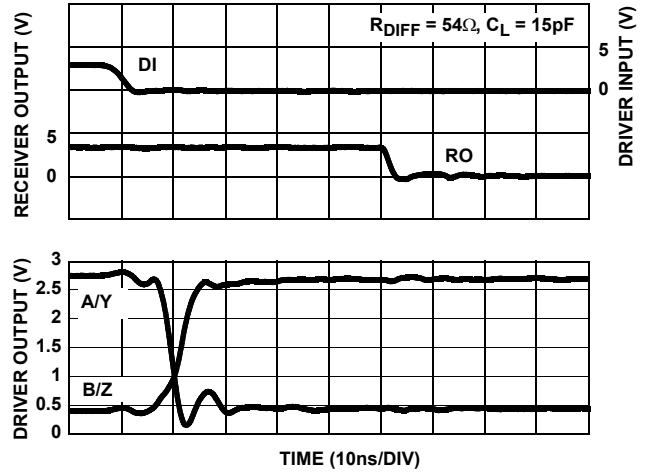


FIGURE 15. DRIVER AND RECEIVER WAVEFORMS, HIGH TO LOW

Die Characteristics

SUBSTRATE POTENTIAL (POWERED UP):

GND

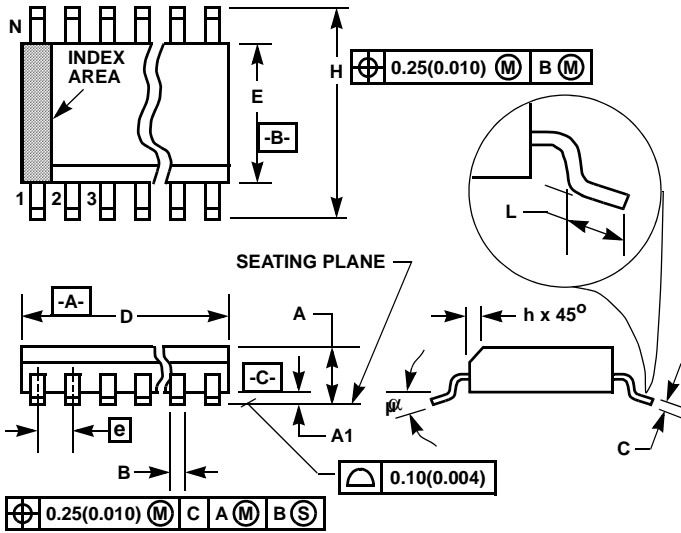
TRANSISTOR COUNT:

528

PROCESS:

Si Gate BiCMOS

Small Outline Plastic Packages (SOIC)



**M8.15 (JEDEC MS-012-AA ISSUE C)
8 LEAD NARROW BODY SMALL OUTLINE PLASTIC
PACKAGE**

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.0532	0.0688	1.35	1.75	-
A1	0.0040	0.0098	0.10	0.25	-
B	0.013	0.020	0.33	0.51	9
C	0.0075	0.0098	0.19	0.25	-
D	0.1890	0.1968	4.80	5.00	3
E	0.1497	0.1574	3.80	4.00	4
e	0.050 BSC		1.27 BSC		-
H	0.2284	0.2440	5.80	6.20	-
h	0.0099	0.0196	0.25	0.50	5
L	0.016	0.050	0.40	1.27	6
N	8		8		7
α	0°	8°	0°	8°	-

NOTES:

1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
3. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm (0.010 inch) per side.
5. The chamfer on the body is optional. If it is not present, a visual index feature must be located within the crosshatched area.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

Rev. 0 12/93

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